

## Preliminary datasheet

### EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC

#### Features

- Electrical features
  - $V_{DSS} = 1200\text{ V}$
  - $I_{DN} = 30\text{ A} / I_{DRM} = 60\text{ A}$
  - Low inductive design
  - High current density
- Mechanical features
  - Integrated NTC temperature sensor
  - PressFIT contact technology
  - Rugged mounting due to integrated mounting clamps



Typical appearance

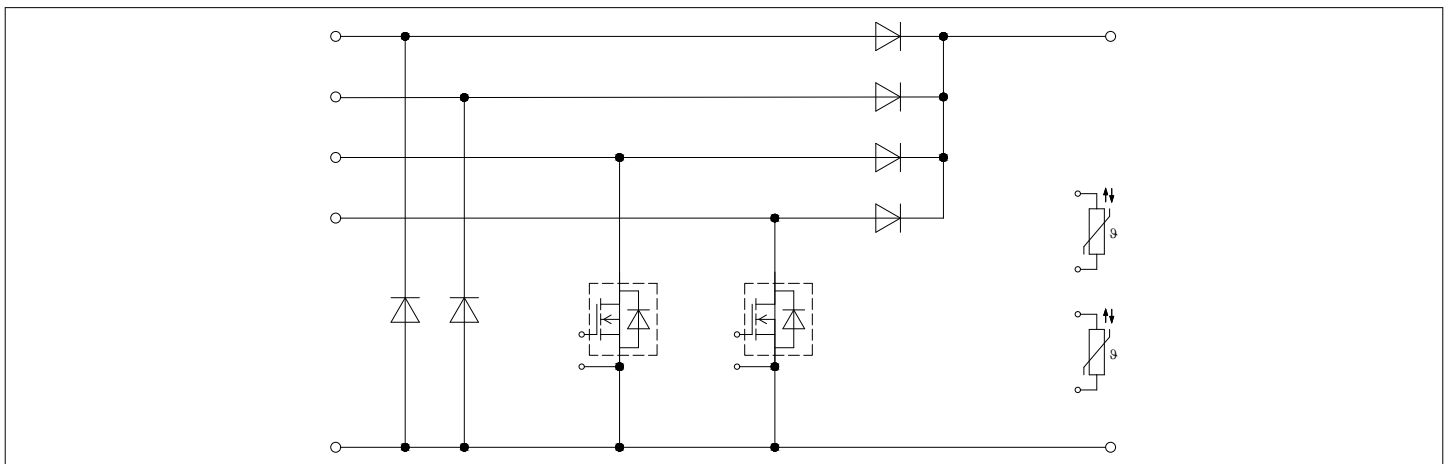
#### Potential applications

- Solar applications

#### Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

#### Description



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## 1 Package

**Table 1 Insulation coordination**

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	$V_{ISOL}$	RMS, $f = 50$ Hz, $t = 60$ min	3.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	$Al_2O_3$	
Comparative tracking index	$CTI$		> 200	
Relative thermal index (electrical)	$RTI$	housing	140	°C

**Table 2 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	$L_{sCE}$			10		nH
Module lead resistance, terminals - chip	$R_{AA'+CC'}$	$T_H = 25$ °C, per switch		3		mΩ
Module lead resistance, terminals - chip	$R_{CC'+EE'}$	$T_H = 25$ °C, per switch		2		mΩ
Storage temperature	$T_{stg}$		-40		125	°C
Mounting force per clamp	$F$		20		50	N
Weight	$G$			24		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.

## 2 MOSFET

**Table 3 Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
Drain-source voltage	$V_{DSS}$	$T_{vj} = 25$ °C	1200	V
Continuous DC drain current	$I_{DDC}$	$T_{vj} = 175$ °C, $V_{GS} = 18$ V $T_H = 90$ °C	30	A
Repetitive peak drain current	$I_{DRM}$	verified by design, $t_p$ limited by $T_{vjmax}$	60	A
Gate-source voltage, max. transient voltage	$V_{GS}$	$D < 0.01$	-10/23	V
Gate-source voltage, max. static voltage	$V_{GS}$		-7/20	V

**Table 4 Recommended values**

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

**Table 5 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit	
			Min.	Typ.	Max.		
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 30\text{ A}$	$V_{GS} = 18\text{ V}, T_{vj} = 25\text{ °C}$		26.4		mΩ
			$V_{GS} = 18\text{ V}, T_{vj} = 125\text{ °C}$		42.8		
			$V_{GS} = 18\text{ V}, T_{vj} = 175\text{ °C}$		56.8		
			$V_{GS} = 15\text{ V}, T_{vj} = 25\text{ °C}$		31.8		
Gate threshold voltage	$V_{GS(th)}$	$I_D = 12\text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25\text{ °C},$ (tested after 1ms pulse at $V_{GS} = +20\text{ V}$ )	3.45	4.3	5.15	V	
Total gate charge	$Q_G$	$V_{DD} = 800\text{ V}, V_{GS} = -3/18\text{ V}$		0.09		μC	
Internal gate resistor	$R_{Gint}$	$T_{vj} = 25\text{ °C}$		3.8		Ω	
Input capacitance	$C_{ISS}$	$f = 0\text{ kHz}, V_{AC} = \text{N/A}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$		2.7		nF	
Output capacitance	$C_{OSS}$	$f = 0\text{ kHz}, V_{AC} = \text{N/A}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$		0.128		nF	
Reverse transfer capacitance	$C_{RSS}$	$f = 0\text{ kHz}, V_{AC} = \text{N/A}, V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$		0.009		nF	
$C_{OSS}$ stored energy	$E_{OSS}$	$V_{DS} = 800\text{ V}, V_{GS} = -3/18\text{ V}, T_{vj} = 25\text{ °C}$		52.4		μJ	
Drain-source leakage current	$I_{DSS}$	$V_{DS} = 1200\text{ V}, V_{GS} = -3\text{ V}$		0.02	210	μA	
Gate-source leakage current	$I_{GSS}$	$V_{DS} = 0\text{ V}, T_{vj} = 25\text{ °C}$			400	nA	
Turn-on delay time (inductive load)	$t_{d\ on}$	$I_D = 30\text{ A}, R_{Gon} = 1.8\text{ Ω}, V_{DD} = 600\text{ V}, V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$		23.6		ns
			$T_{vj} = 125\text{ °C}$		23.6		
			$T_{vj} = 175\text{ °C}$		23.6		
Rise time (inductive load)	$t_r$	$I_D = 30\text{ A}, R_{Gon} = 1.8\text{ Ω}, V_{DD} = 600\text{ V}, V_{GS} = -3/18\text{ V}$	$T_{vj} = 25\text{ °C}$		17		ns
			$T_{vj} = 125\text{ °C}$		17		
			$T_{vj} = 175\text{ °C}$		17		

**(table continues...)**

**Table 5 (continued) Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 30\ A, R_{Goff} = 2.7\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	51.6		ns
			$T_{vj} = 125\ ^\circ C$	51.6		
			$T_{vj} = 175\ ^\circ C$	51.6		
Fall time (inductive load)	$t_f$	$I_D = 30\ A, R_{Goff} = 2.7\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$	11		ns
			$T_{vj} = 125\ ^\circ C$	11		
			$T_{vj} = 175\ ^\circ C$	11		
Turn-on energy loss per pulse	$E_{on}$	$I_D = 30\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Gon} = 1.8\ \Omega, di/dt = 3.42\ kA/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	0.266		mJ
			$T_{vj} = 125\ ^\circ C$	0.266		
			$T_{vj} = 175\ ^\circ C$	0.266		
Turn-off energy loss per pulse	$E_{off}$	$I_D = 30\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Goff} = 2.7\ \Omega, dv/dt = 43.6\ kV/\mu s (T_{vj} = 175\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$	0.058		mJ
			$T_{vj} = 125\ ^\circ C$	0.058		
			$T_{vj} = 175\ ^\circ C$	0.058		
Thermal resistance, junction to heat sink	$R_{thJH}$	per MOSFET		1.25		K/W
Temperature under switching conditions	$T_{vj\ op}$		-40		175	$^\circ C$

*Note:* The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

$T_{vj,op} > 150\ ^\circ C$  is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

### 3 Body diode

**Table 6 Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
DC body diode forward current	$I_{SD}$	$T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V, T_H = 90\ ^\circ C$	16	A

**Table 7 Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_{SD}$	$I_{SD} = 30\ A, V_{GS} = -3\ V$	$T_{vj} = 25\ ^\circ C$	4.2	5.35	V
			$T_{vj} = 125\ ^\circ C$	3.9		
			$T_{vj} = 175\ ^\circ C$	3.8		

## 4 Diode, Boost

**Table 8** Maximum rated values

Parameter	Symbol	Note or test condition	Values		Unit
			Min.	Max.	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj} = 25\text{ °C}$	1200		V
Continuous DC forward current	$I_F$		40		A
Repetitive peak forward current	$I_{FRM}$	$t_p = 1\text{ ms}$	80		A
$I^2t$ - value	$I^2t$	$t_p = 10\text{ ms}, V_R = 0\text{ V}$	$T_{vj} = 125\text{ °C}$	320	A <sup>2</sup> s
			$T_{vj} = 150\text{ °C}$	295	

**Table 9** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F = 40\text{ A}, V_{GE} = 0\text{ V}$	$T_{vj} = 25\text{ °C}$	1.40	1.85	V
			$T_{vj} = 125\text{ °C}$	1.70		
			$T_{vj} = 150\text{ °C}$	1.85		
Peak reverse recovery current	$I_{RM}$	$V_{CC} = 600\text{ V}, I_F = 40\text{ A}, -di_F/dt = 4000\text{ A}/\mu\text{s} (T_{vj} = 150\text{ °C})$	$T_{vj} = 25\text{ °C}$	41.4		A
			$T_{vj} = 125\text{ °C}$	41.4		
			$T_{vj} = 150\text{ °C}$	41.4		
Recovered charge	$Q_r$	$V_{CC} = 600\text{ V}, I_F = 40\text{ A}, -di_F/dt = 4000\text{ A}/\mu\text{s} (T_{vj} = 150\text{ °C})$	$T_{vj} = 25\text{ °C}$	4.58		$\mu\text{C}$
			$T_{vj} = 125\text{ °C}$	4.58		
			$T_{vj} = 150\text{ °C}$	4.58		
Reverse recovery energy	$E_{rec}$	$V_{CC} = 600\text{ V}, I_F = 40\text{ A}, -di_F/dt = 4000\text{ A}/\mu\text{s} (T_{vj} = 150\text{ °C})$	$T_{vj} = 25\text{ °C}$	0.048		mJ
			$T_{vj} = 125\text{ °C}$	0.048		
			$T_{vj} = 150\text{ °C}$	0.048		
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		1.11		K/W
Temperature under switching conditions	$T_{vj\text{ op}}$		-40		150	°C

## 5 Bypass-diode

**Table 10** Maximum rated values

Parameter	Symbol	Note or test condition	Values		Unit
			Min.	Max.	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj} = 25\text{ °C}$	1200		V

(table continues...)

**Table 10** (continued) Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Maximum RMS forward current per chip	$I_{FRMSM}$	$T_H = 80\text{ °C}$	50	A	
Maximum RMS current at rectifier output	$I_{RMSM}$	$T_H = 80\text{ °C}$	50	A	
Surge forward current	$I_{FSM}$	$t_p = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	450	A
			$T_{vj} = 150\text{ °C}$	360	
$I^2t$ - value	$I^2t$	$t_p = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	1010	A <sup>2</sup> s
			$T_{vj} = 150\text{ °C}$	648	

**Table 11** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F = 30\text{ A}$ , $T_{vj} = 150\text{ °C}$		0.95		V
Reverse current	$I_r$	$T_{vj} = 150\text{ °C}$ , $V_R = 1200\text{ V}$		0.1		mA
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		1.29		K/W
Temperature under switching conditions	$T_{vj, op}$		-40		150	°C

## 6 Inverse-polarity protection diode

**Table 12** Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj} = 25\text{ °C}$	1200	V	
Maximum RMS forward current per chip	$I_{FRMSM}$	$T_H = 80\text{ °C}$	50	A	
Maximum RMS current at rectifier output	$I_{RMSM}$	$T_H = 80\text{ °C}$	50	A	
Surge forward current	$I_{FSM}$	$t_p = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	450	A
			$T_{vj} = 150\text{ °C}$	360	
$I^2t$ - value	$I^2t$	$t_p = 10\text{ ms}$	$T_{vj} = 25\text{ °C}$	1010	A <sup>2</sup> s
			$T_{vj} = 150\text{ °C}$	648	

**Table 13** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F = 30 \text{ A}$ $T_{vj} = 150 \text{ °C}$		0.95		V
Reverse current	$I_r$	$T_{vj} = 150 \text{ °C}$ , $V_R = 1200 \text{ V}$		0.1		mA
Thermal resistance, junction to heat sink	$R_{thJH}$	per diode		1.16		K/W
Temperature under switching conditions	$T_{vj, op}$		-40		150	°C

## 7 NTC-Thermistor

**Table 14** Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	$R_{25}$	$T_{NTC} = 25 \text{ °C}$		5		kΩ
Deviation of $R_{100}$	$\Delta R/R$	$T_{NTC} = 100 \text{ °C}$ , $R_{100} = 493 \text{ Ω}$	-5		5	%
Power dissipation	$P_{25}$	$T_{NTC} = 25 \text{ °C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

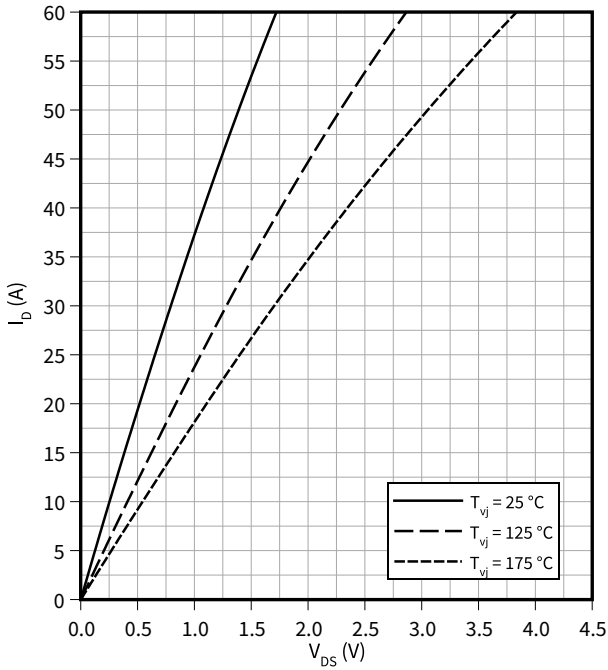
Note: Specification according to the valid application note.



## 8 Characteristics diagrams

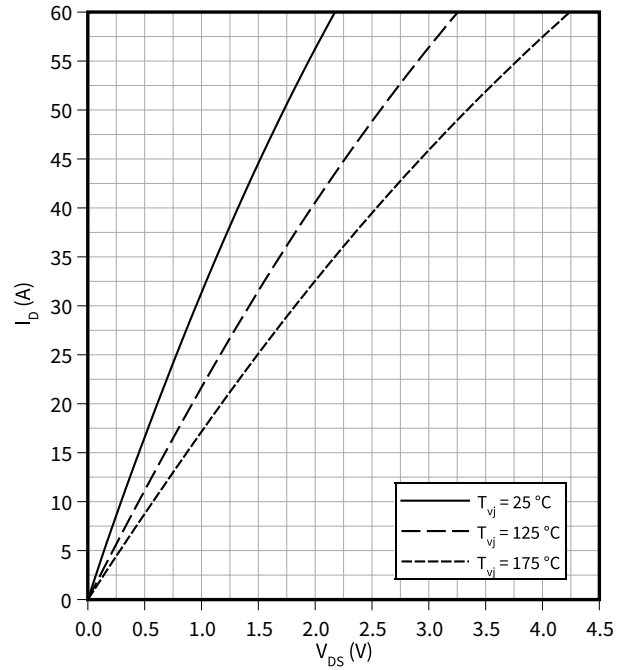
**Output characteristic (typical), MOSFET**

$I_D = f(V_{DS})$   
 $V_{GS} = 18\text{ V}$



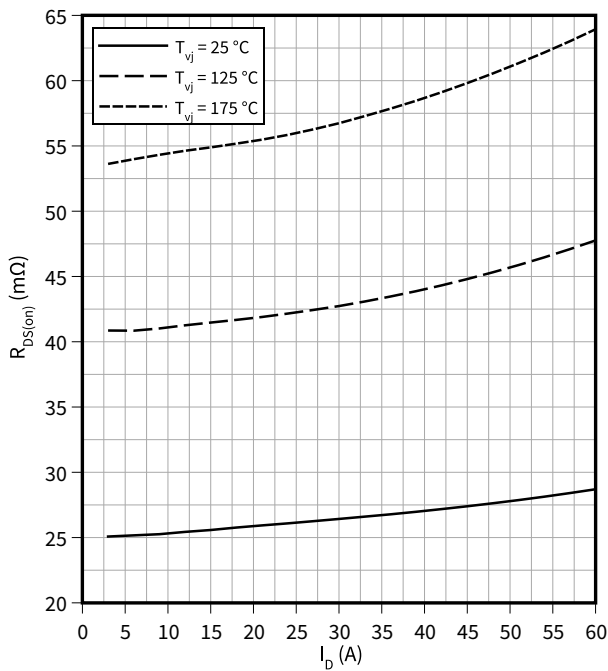
**Output characteristic (typical), MOSFET**

$I_D = f(V_{DS})$   
 $V_{GS} = 15\text{ V}$



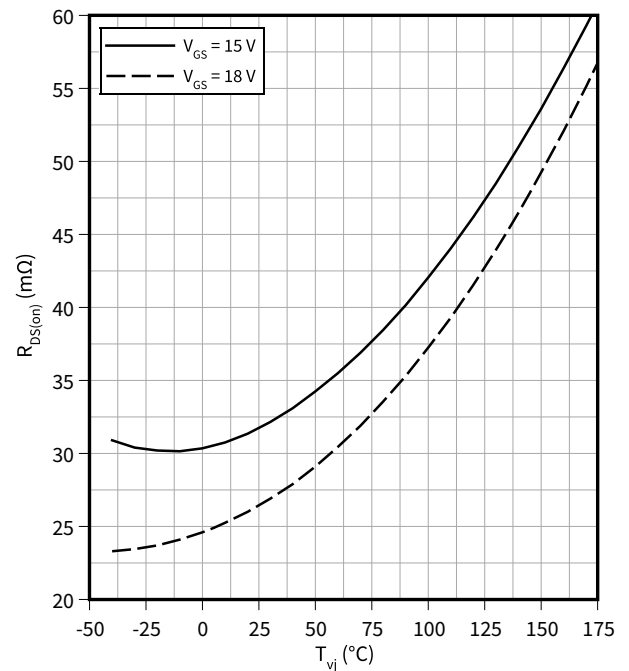
**Drain source on-resistance (typical), MOSFET**

$R_{DS(on)} = f(I_D)$   
 $V_{GS} = 18\text{ V}$



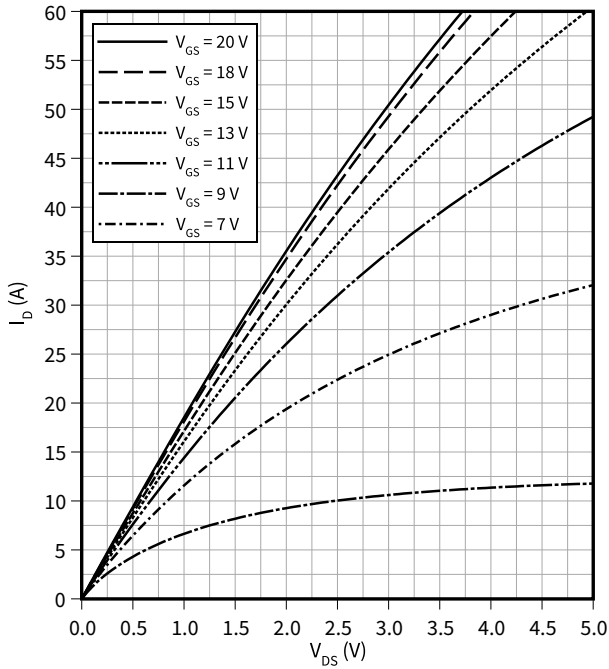
**Drain source on-resistance (typical), MOSFET**

$R_{DS(on)} = f(T_{vj})$   
 $I_D = 30\text{ A}$



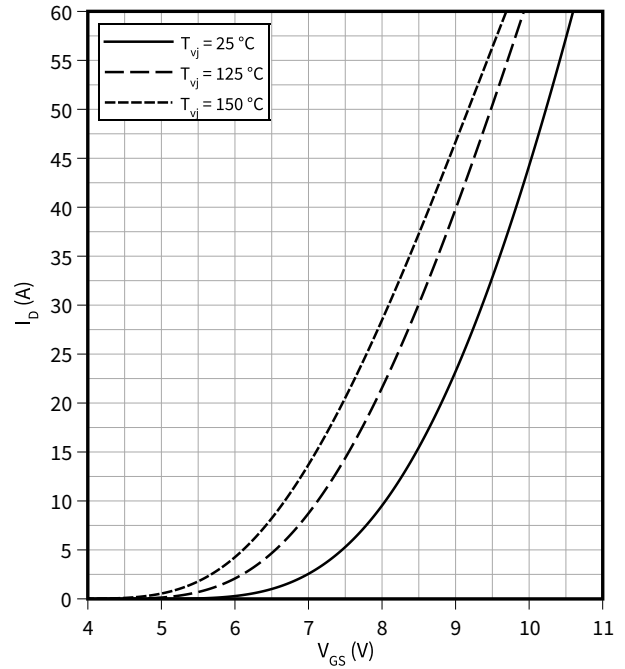
**Output characteristic field (typical), MOSFET**

$I_D = f(V_{DS})$   
 $T_{vj} = 175\text{ °C}$



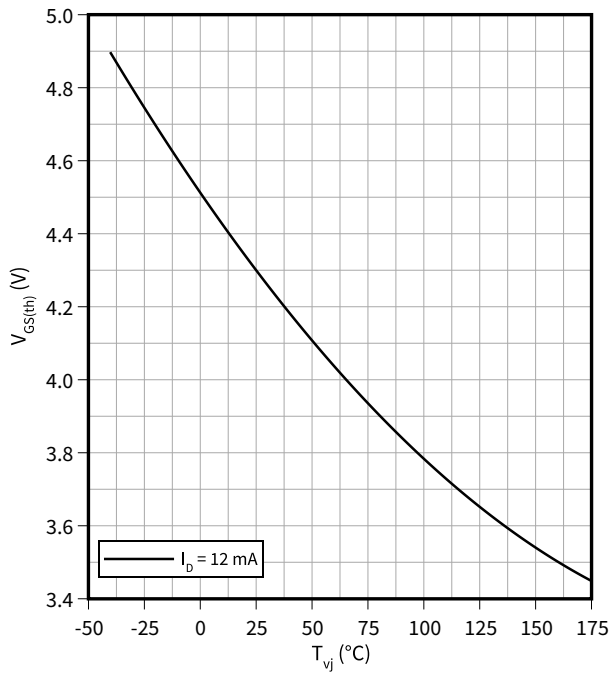
**Transfer characteristic (typical), MOSFET**

$I_D = f(V_{GS})$   
 $V_{DS} = 20\text{ V}$



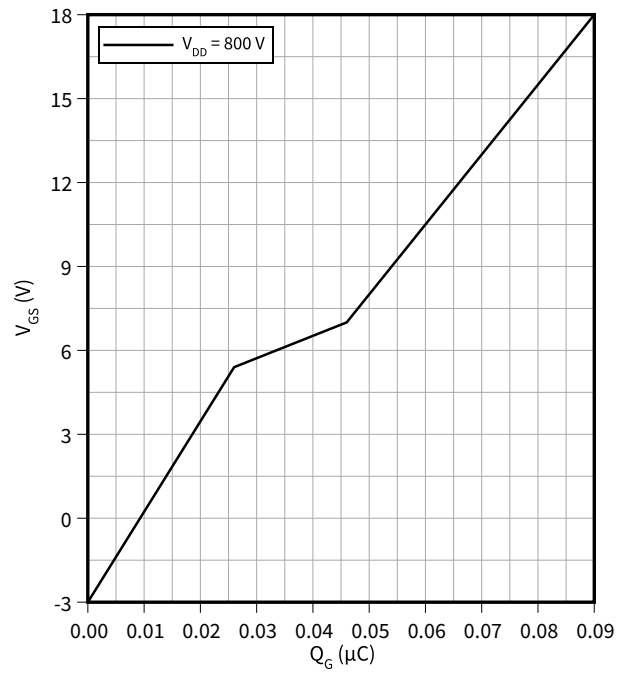
**Gate-source threshold voltage (typical), MOSFET**

$V_{GS(th)} = f(T_{vj})$   
 $V_{GS} = V_{DS}$



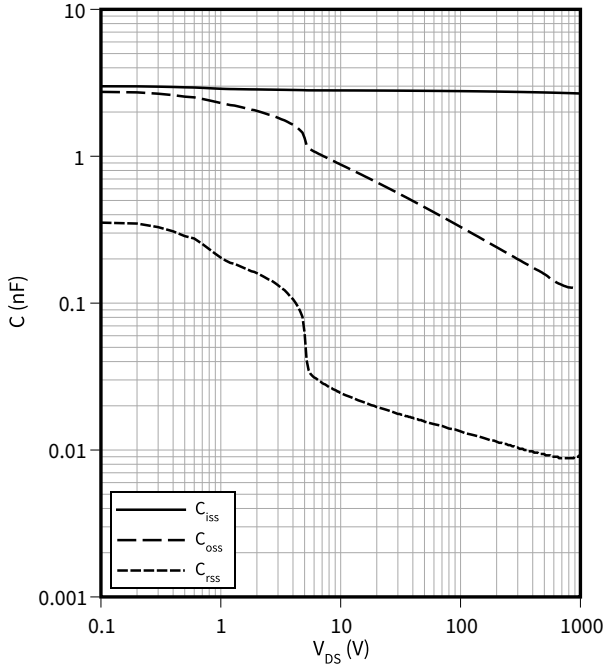
**Gate charge characteristic (typical), MOSFET**

$V_{GS} = f(Q_G)$   
 $I_D = 30\text{ A}, T_{vj} = 25\text{ °C}$



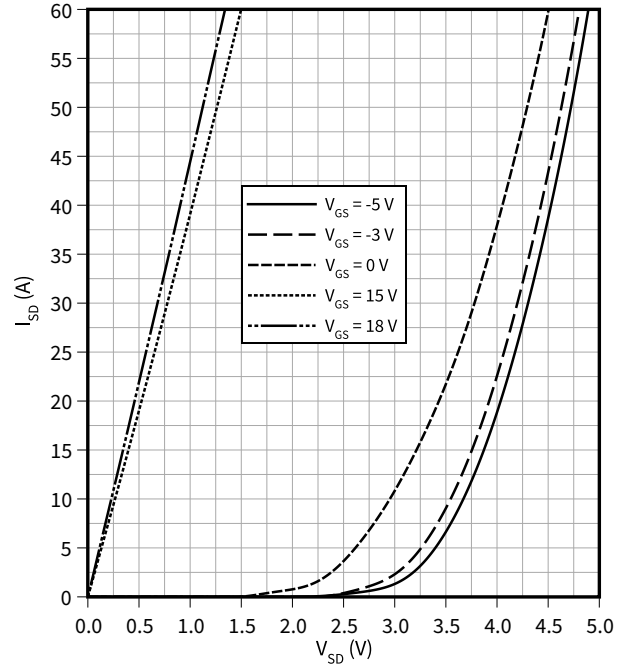
**Capacity characteristic (typical), MOSFET**

$C = f(V_{DS})$   
 $f = 100 \text{ kHz}, T_{vj} = 25 \text{ }^\circ\text{C}, V_{GS} = 0 \text{ V}$



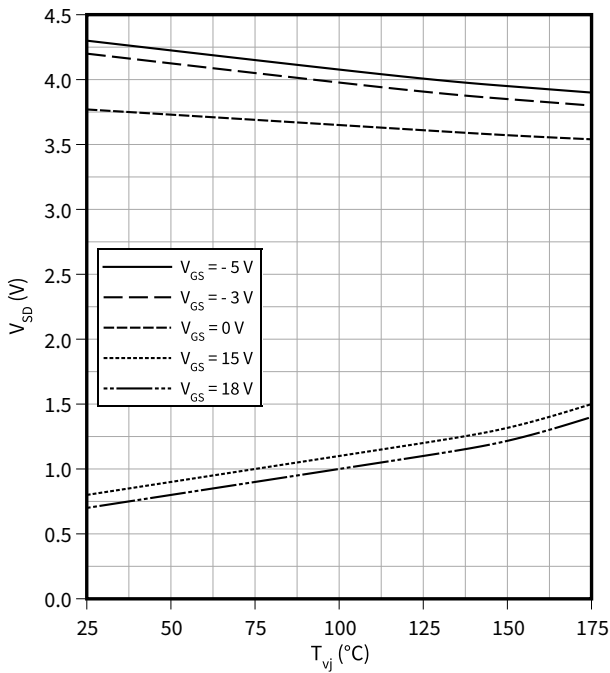
**Forward characteristic body diode (typical), MOSFET**

$I_{SD} = f(V_{SD})$   
 $T_{vj} = 25 \text{ }^\circ\text{C}$



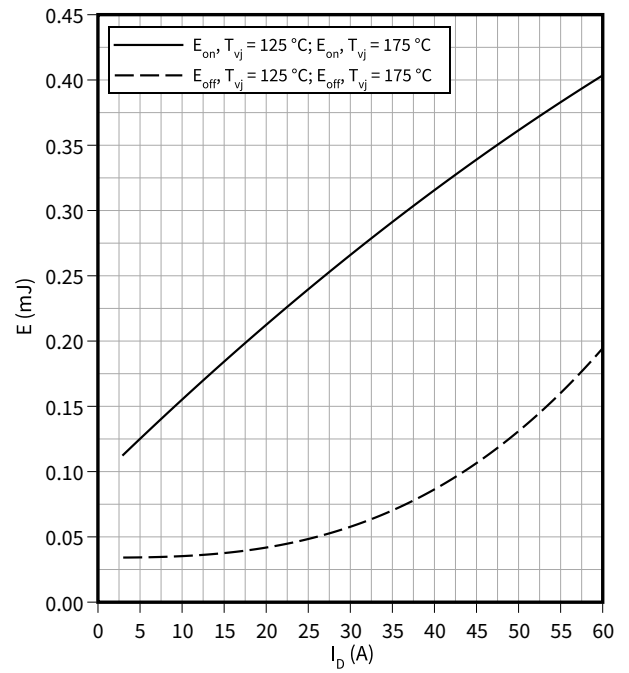
**Forward voltage of body diode (typical), MOSFET**

$V_{SD} = f(T_{vj})$   
 $I_{SD} = 30 \text{ A}$



**Switching losses (typical), MOSFET**

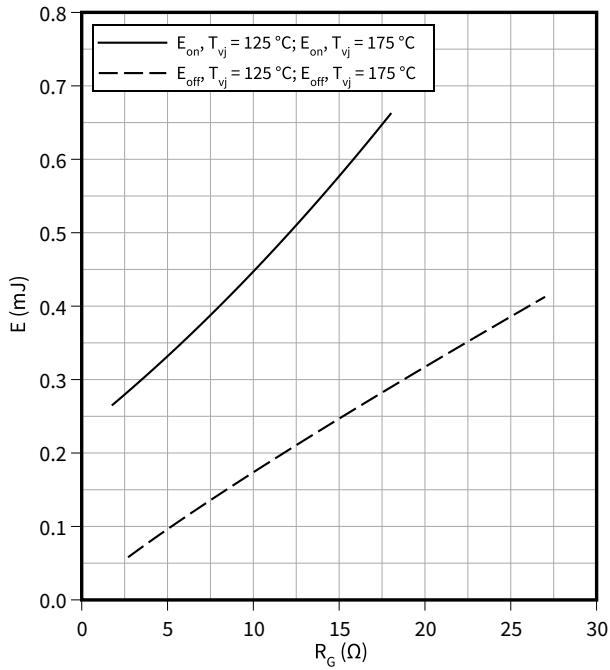
$E = f(I_D)$   
 $R_{Goff} = 2.7 \text{ } \Omega, R_{Gon} = 1.8 \text{ } \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$



**Switching losses (typical), MOSFET**

$E = f(R_G)$

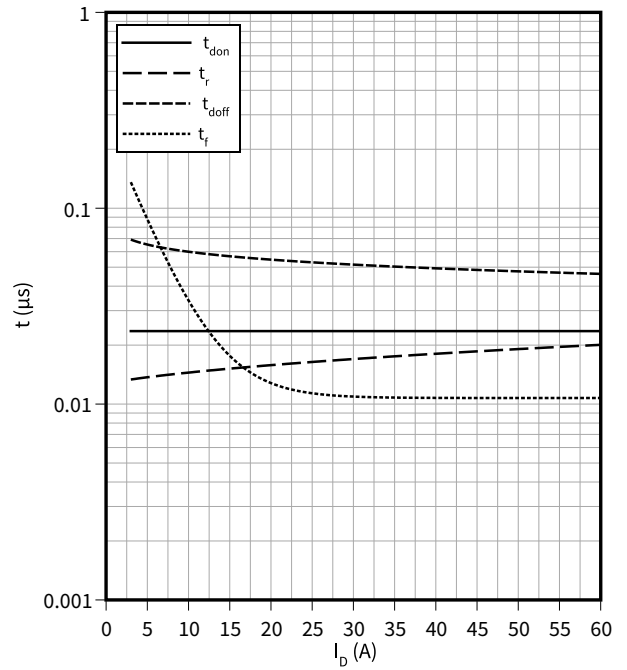
$V_{DD} = 600\text{ V}, I_D = 30\text{ A}, V_{GS} = -3/18\text{ V}$



**Switching times (typical), MOSFET**

$t = f(I_D)$

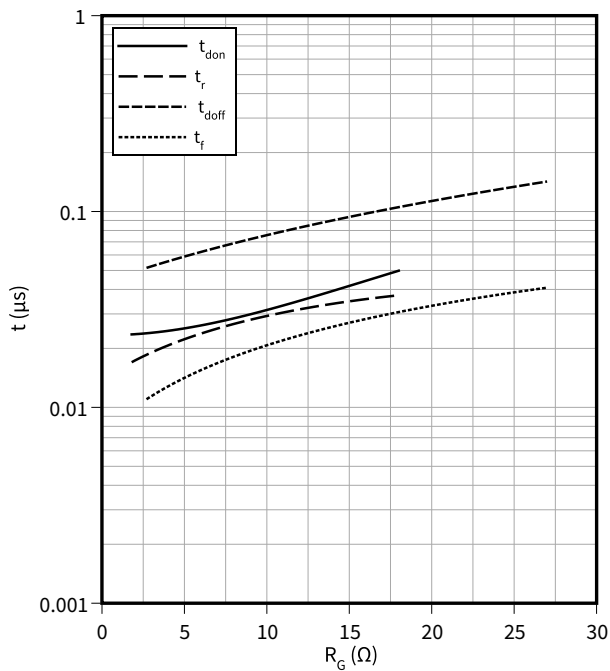
$R_{Goff} = 2.7\ \Omega, R_{Gon} = 1.8\ \Omega, V_{DD} = 600\text{ V}, T_{vj} = 175\ \text{°C}, V_{GS} = -3/18\text{ V}$



**Switching times (typical), MOSFET**

$t = f(R_G)$

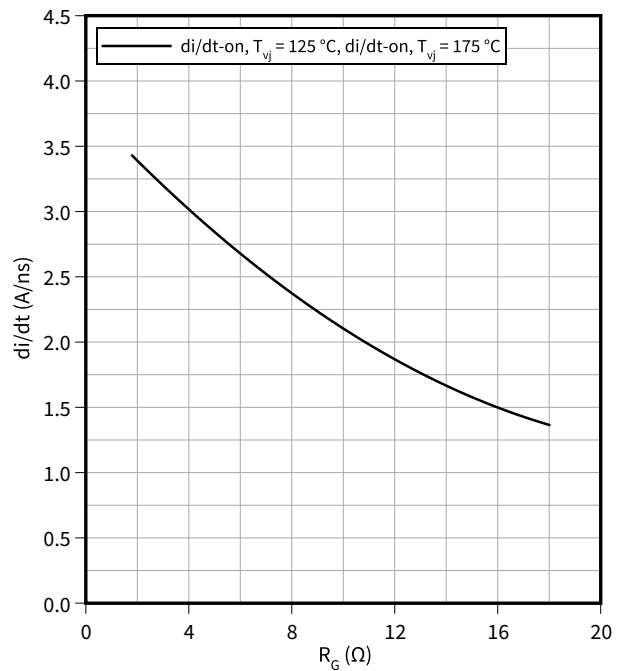
$V_{DD} = 600\text{ V}, I_D = 30\text{ A}, T_{vj} = 175\ \text{°C}, V_{GS} = -3/18\text{ V}$



**Current slope (typical), MOSFET**

$di/dt = f(R_G)$

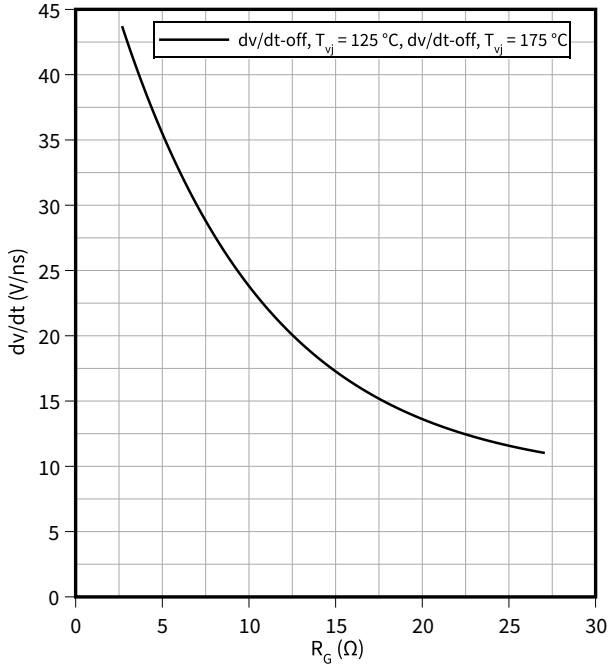
$V_{DD} = 600\text{ V}, I_D = 30\text{ A}, V_{GS} = -3/18\text{ V}$



**Voltage slope (typical), MOSFET**

$dv/dt = f(R_G)$

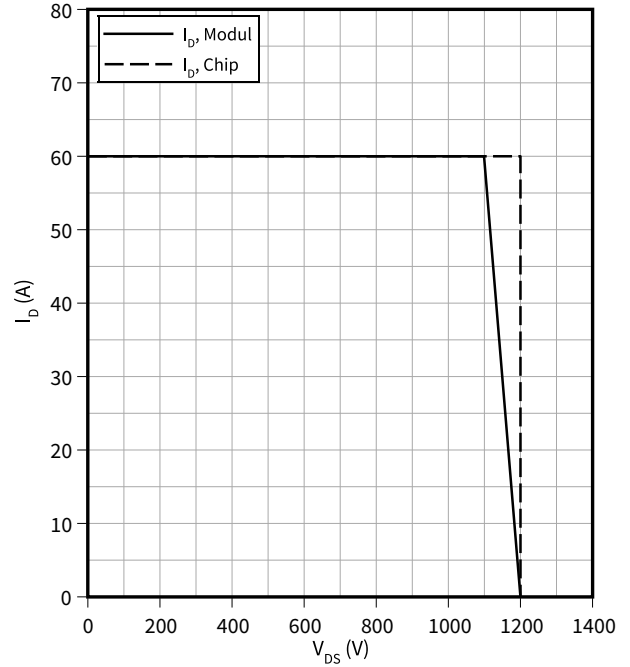
$V_{DD} = 600\text{ V}, I_D = 30\text{ A}, V_{GS} = -3/18\text{ V}$



**Reverse bias safe operating area (RBSOA), MOSFET**

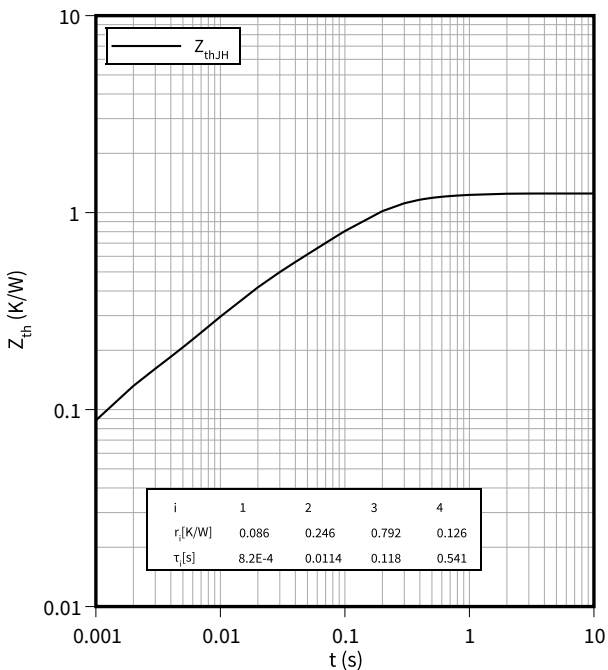
$I_D = f(V_{DS})$

$R_{Goff} = 2.7\ \Omega, T_{vj} = 175\ ^\circ\text{C}, V_{GS} = -3/18\text{ V}$



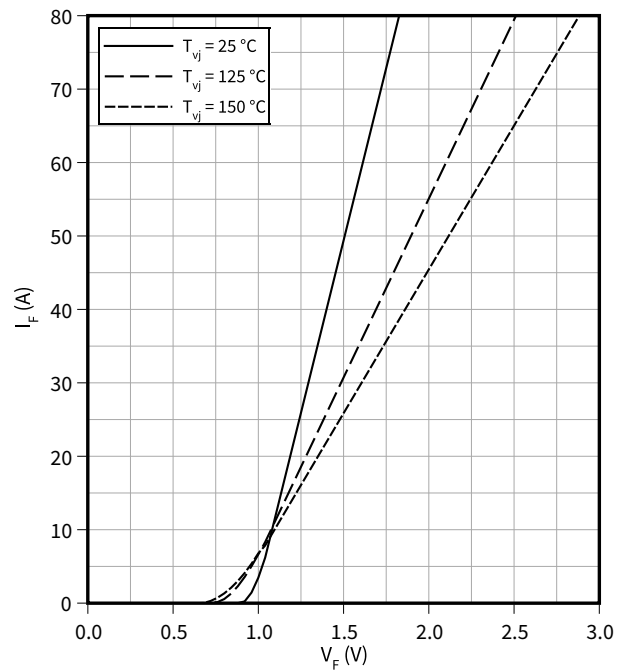
**Transient thermal impedance, MOSFET**

$Z_{th} = f(t)$



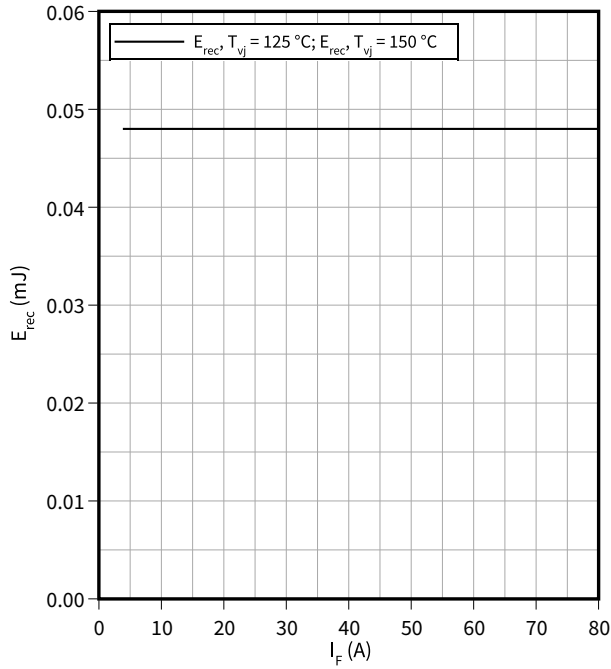
**Forward characteristic (typical), Diode, Boost**

$I_F = f(V_F)$



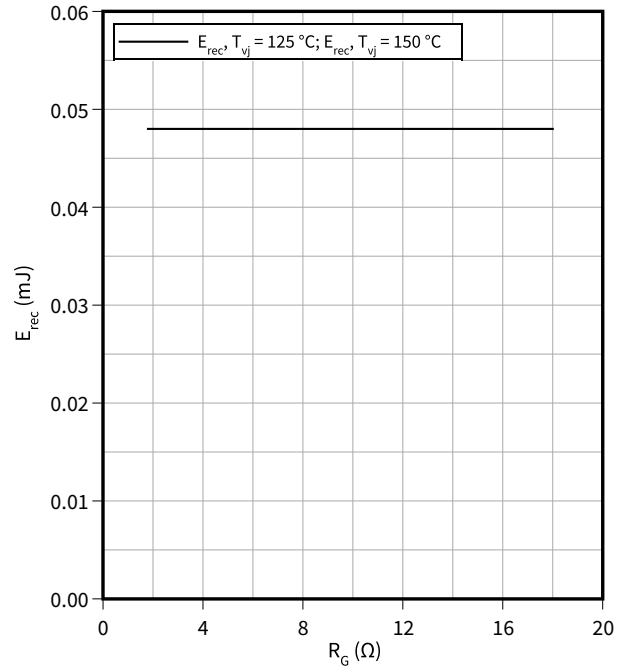
**Switching losses (typical), Diode, Boost**

$E_{rec} = f(I_F)$   
 $R_{Gon} = 1.8 \Omega, V_{CC} = 600 V$



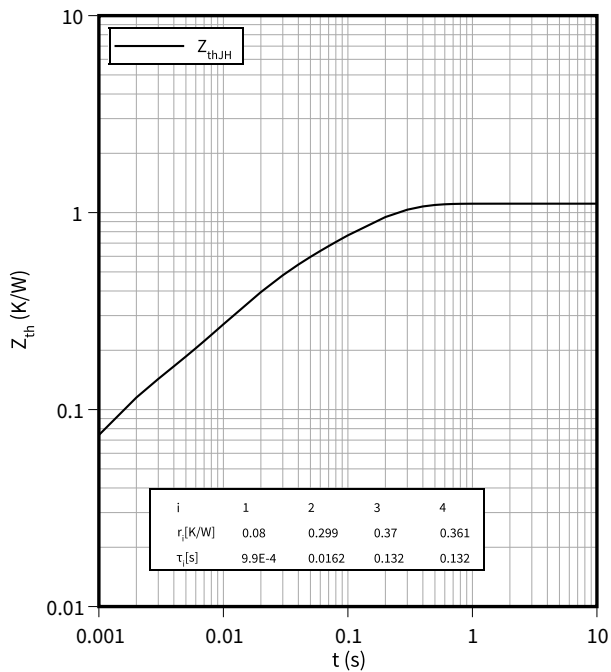
**Switching losses (typical), Diode, Boost**

$E_{rec} = f(R_G)$   
 $I_F = 40 A, V_{CC} = 600 V$



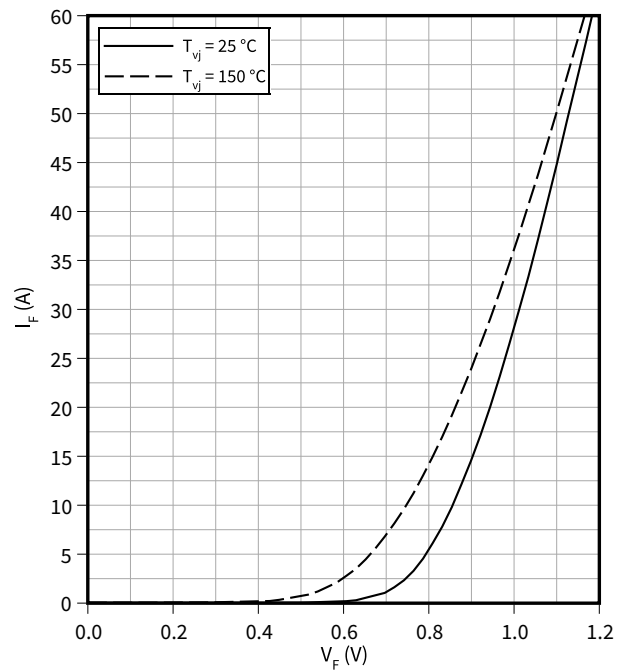
**Transient thermal impedance, Diode, Boost**

$Z_{th} = f(t)$



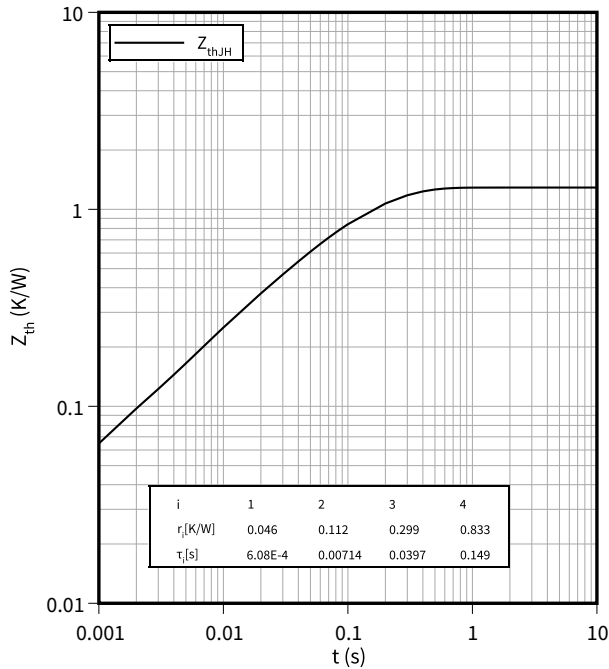
**Forward characteristic (typical), Bypass-diode**

$I_F = f(V_F)$



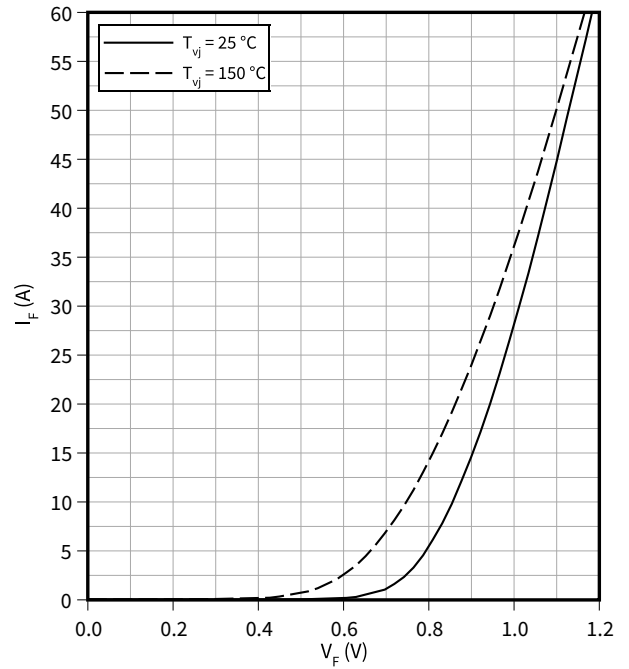
**Transient thermal impedance, Bypass-diode**

$Z_{th} = f(t)$



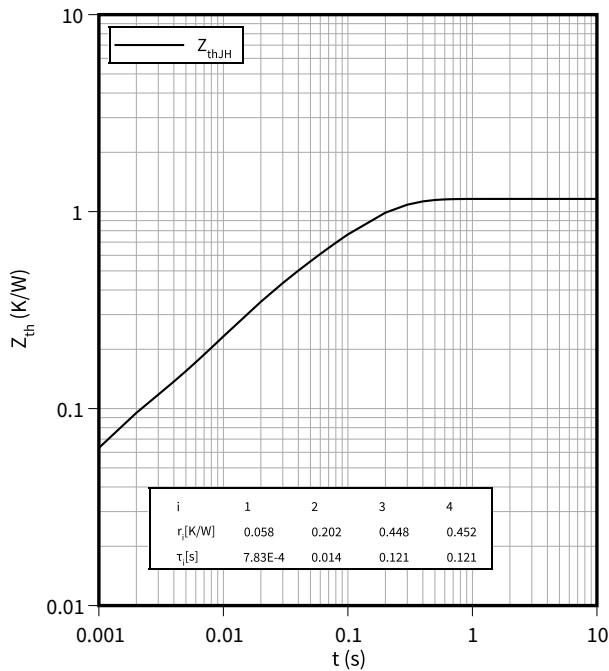
**Forward characteristic (typical), Inverse-polarity protection diode**

$I_F = f(V_F)$



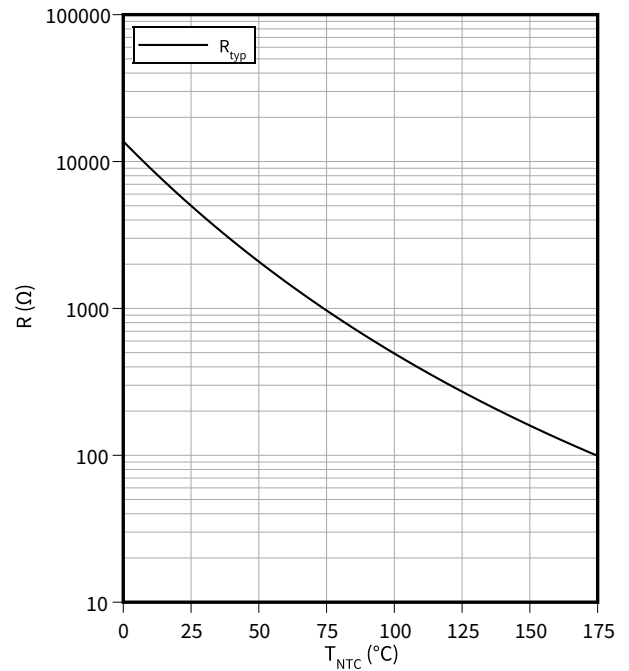
**Transient thermal impedance, Inverse-polarity protection diode**

$Z_{th} = f(t)$



**Temperature characteristic (typical), NTC-Thermistor**

$R = f(T_{NTC})$



## 9 Circuit diagram

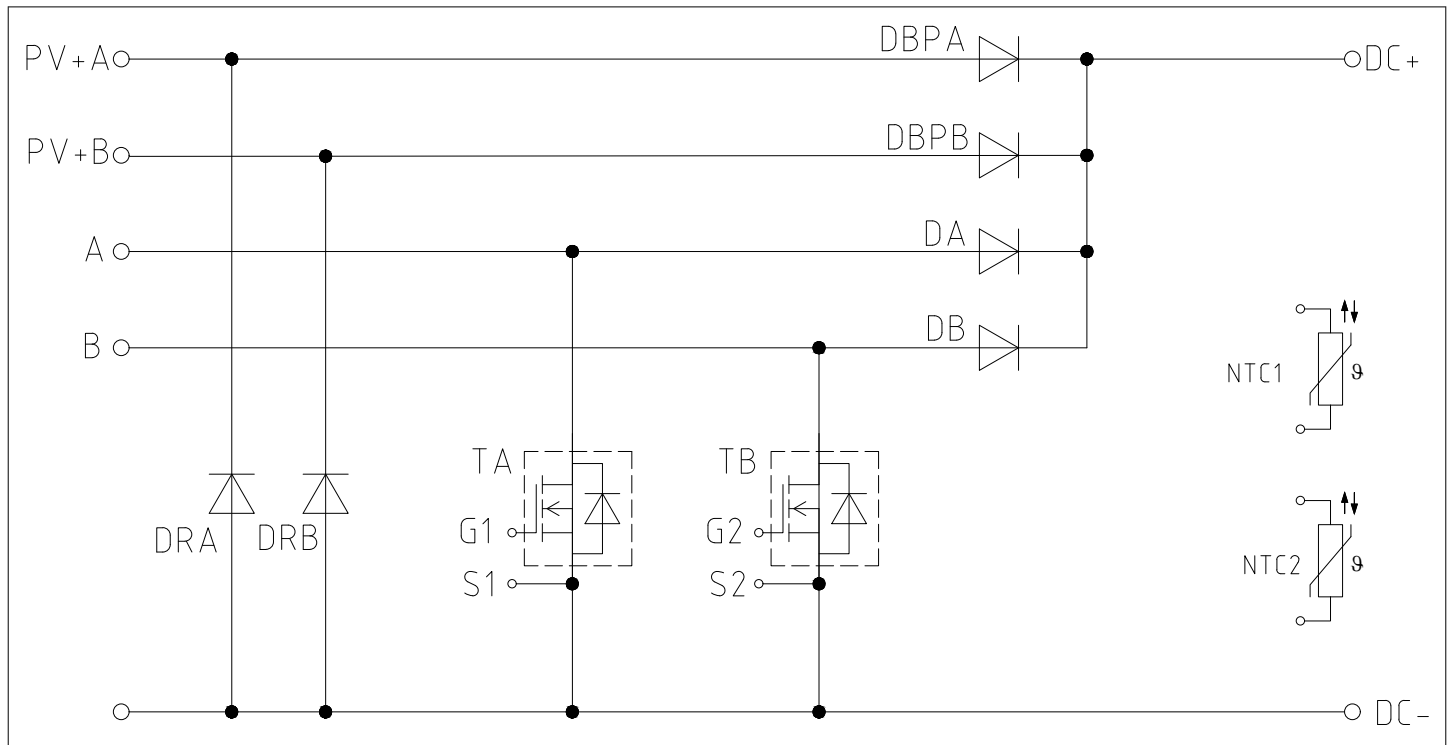


Figure 1



10 Package outlines

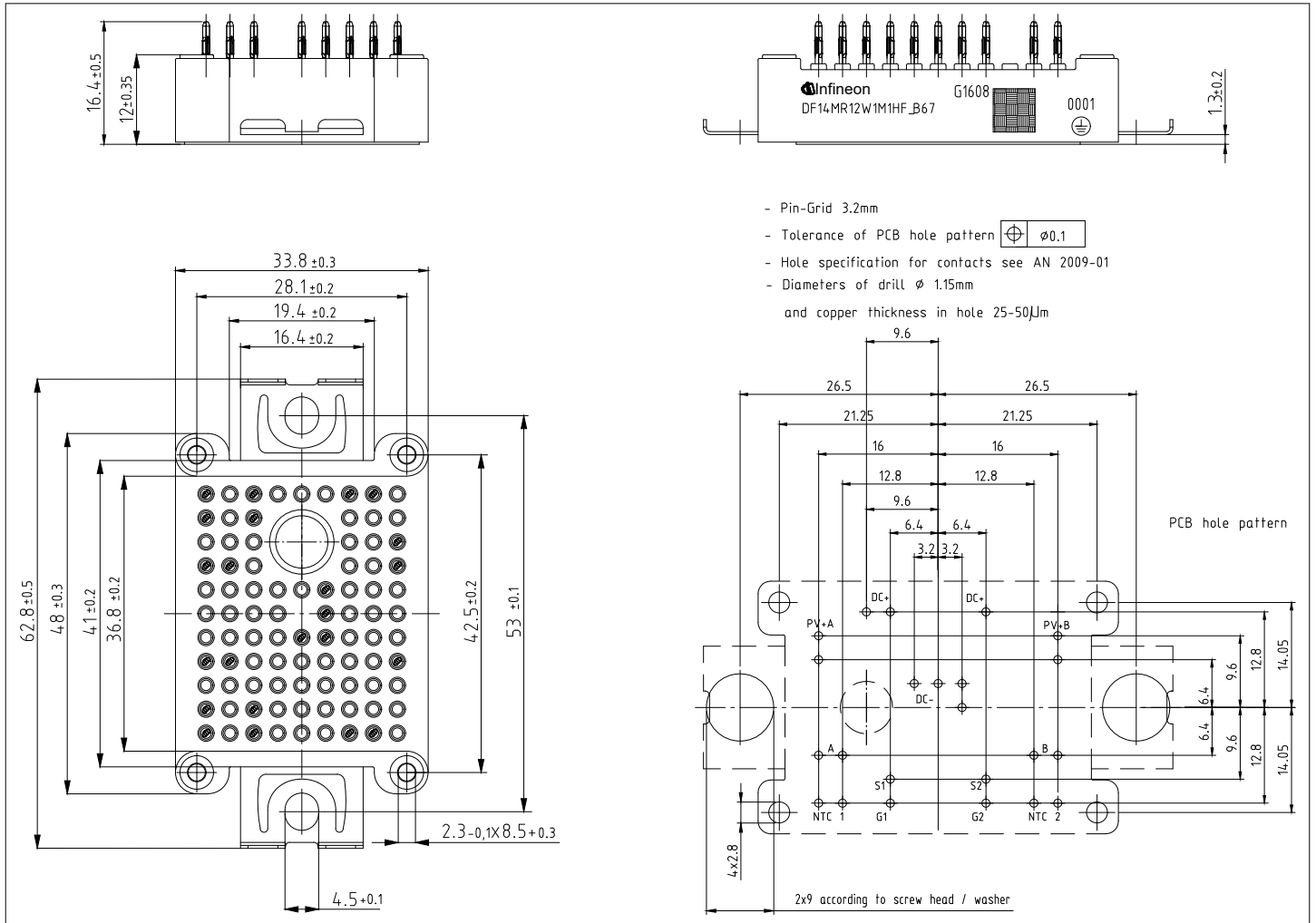

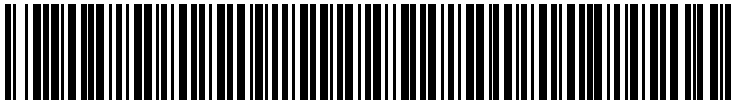


Figure 2

## 11 Module label code

Module label code			
Code format	Data Matrix	Barcode Code128	
Encoding	ASCII text	Code Set A	
Symbol size	16x16	23 digits	
Standard	IEC24720 and IEC16022	IEC8859-1	
Code content	<i>Content</i> Module serial number Module material number Production order number Date code (production year) Date code (production week)	<i>Digit</i> 1 - 5 6 - 11 12 - 19 20 - 21 22 - 23	<i>Example</i> 71549 142846 55054991 15 30
Example	 		
	<p>71549142846550549911530</p> <p>71549142846550549911530</p>		

**Figure 3**

## Revision history

Document version	Date of release	Description of changes
0.10	2022-11-24	Initial version

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**Document reference**

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